

Search Notes

Application/Control No.

10/768,443

Examiner

Trung Q. Nguyen

Applicant(s)/Patent under
Reexamination

WARE ET AL.

Art Unit

2829

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Search Keywords: test near circuit\$1 same element\$1 same transmitter same receiver.	2/24/2006	QT